Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/633,313	KAMMA, HIROSHI	
Examiner	Art Unit	
DANH C. LE	2683	

	SEARCHED				
Class	Subclass	Date	Examiner		
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+55	411	7/28/05	DCL		
	410				
	412.1				
379	102.03				
340	546				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
Inventor Name Search (For Double Patent Check)	7/28/05	DCL			
EAST Swich USP, USPUB	7/29/05	DUL			
EAST Search DERWENT, JPO, EAO	7/29/05	DCL			
Interference Search					
Lee Ngujen (455)					
Hun Vuong (455)					